Hamiltonian approach to the transport properties of superconducting quantum point contacts

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A microscopic theory of the transport properties of quantum point contacts giving a unified description of the normal conductor-superconductor (N-S) and superconductor-superconductor (S-S) cases is presented. It is based on a model Hamiltonian describing charge transfer processes in the contact region and makes use of nonequilibrium Green function techniques for the calculation of the relevant quantities. It is explicitly shown that when calculations are performed up to infinite order in the coupling between the electrodes, the theory contains all known results predicted by the more usual scattering approach for N-S and S-S contacts. For the latter we introduce a specific formulation for dealing with the nonstationary transport properties. An efficient algorithm is developed for obtaining the dc and ac current components, which allows a detailed analysis of the different current-voltage characteristics for all range of parameters. We finally address the less understood small bias limit, for which some analytical results can be obtained within the present formalism. It is shown that four different physical regimes can be reached in this limit depending on the values of the inelastic scattering rate and the contact transmission. The behavior of the system in these regimes is discussed together with the conditions for their experimental observability. [S0163-1829(96)02034-6]

I. INTRODUCTION

Electronic transport through *N-S* and *S-S* junctions and weak links has been the object of interest for many years.^{1,2} Much of the theoretical understanding of these systems has been obtained by analyzing simple models where a one-dimensional character is assumed.^{2,3} These kinds of models have been very useful for clarifying the microscopic origin of basic phenomena like the excess current in *N-S* and *S-S* contacts and the subgap structure in *S-S* and *S*-insulator-*S* (*S-I-S*) junctions. In particular, the one-dimensional scattering model introduced by Blonder *et al.*³ (hereafter referred to as BTK) has provided a simple way of analyzing the transport properties in terms of normal electron transmission and Andreev reflection probabilities.

With the recent advances in the fabrication of nanoscale devices,^{4,5} a closer comparison between the predictions of simple quasi-one-dimensional theories and experimental results is now at hand. References 4 and 5 provide two different examples of the progress made in the experimental achievement of a superconducting quantum point contact (SQPC). This possibility has provoked a renewed interest in more detailed and quantitative analysis of models involving a few conducting channels. It turns out that, in spite of its apparent simplicity, the case of a single-channel SQPC still contains nontrivial physical behavior at certain regimes. Single-mode contacts have been analyzed recently by different authors^{6–8} who have obtained new quantitative results for the case of small applied voltage where multiple Andreev reflections (MAR's) play a crucial role.

Some of these recent works^{7,8} illustrate the existence of a variety of regimes controlled by the contact transmission and quasiparticle damping in the small bias limit. A full understanding of the different regimes, together with the transitions between them remains to be explored. This will be thoroughly analyzed in this paper.

Traditionally, quantum transport in microelectronic devices has been mainly addressed by two different approaches: one is based on the scattering picture first introduced by Landauer⁹ in which the transport properties are expressed in terms of transmission and reflection scattering amplitudes. This approach is generally used in a phenomenological way by replacing the device with a simple scattering structure. The natural extension of this picture to the superconducting case was provided by the already mentioned BTK model.

A different point of view arises when the problem is analyzed starting from a microscopic Hamiltonian. We shall very generally call "Hamiltonian approach" the theories which take this starting point. The origin of this approach can be traced back to the work by Bardeen who introduced the tunnel Hamiltonian approximation for describing a tunnel junction.¹⁰ Most of the calculations based on this tunnel Hamiltonian were restricted to the lowest order transport processes like in the calculation of the Josephson current in a S-I-S junction.¹¹ Multiparticle tunneling processes (MPT's) were first discussed by Schrieffer and Wilkins¹² as a possible explanation for the observed subgap structure in superconducting tunnel junctions. The contributions of these higher order processes were found to be divergent, which has led to the quite extended belief that the Hamiltonian approach is pathological except for describing the lowest order tunneling processes.

One of the aims of the present work is to show that starting from a very simple model Hamiltonian describing a single-channel contact it is possible to obtain results for N-S and S-S contacts in agreement with those provided by scattering theory. As will be shown below inclusion of higher order processes up to infinite order eliminates the pathologies associated with finite order perturbation theory.

On the other hand, the Hamiltonian approach in combination with nonequilibrium Green function techniques presents

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The paper is organized as follows: In Sec. II the general model for a superconducting weak link in a local representation is introduced. In particular, we discuss how this model can be simplified in order to describe a single-mode contact. We then introduce the nonequilibrium Green function formalism by means of which the total current through the contact can be expressed. In Sec. III we analyze the more simple N-N and N-S contacts. The study of the N-N case allows us to define the contact transmission coefficient in terms of the microscopic parameters of our model. The complete correspondence with the results of the BTK scattering theory is then established by analyzing the N-S contact. For this last case we derive an analytical expression for the total current as a function of the contact transmission. Section IV is devoted to the S-S case. We first show how the problem of the calculation of the ac current components can be reduced to the evaluation of an algebraic set of linear equations. This allows us to study in detail the general features of the dc and ac I-V characteristics for the whole range of voltages and transmissions. We finally concentrate on the limit $V \ll \Delta$ where the more interesting and less understood physics takes place. Section V is devoted to some concluding remarks.

II. MODEL AND METHOD

In this paper we shall consider "point-contact-like" geometries consisting very generally of two wide (3D or 2D) electrodes connected by a narrow constriction. The constriction length, L_C , is assumed to be much smaller than the superconducting coherence length and its width, W_C , comparable to the Fermi wavelength , λ_F . For a sufficiently short constriction the detailed form of the self-consistent order parameter and electrostatic potential in the region between the electrodes becomes irrelevant¹³ allowing us to represent them by simple step functions. On the other hand, the condition $W_C \sim \lambda_F$ implies that there is only a reduced number of quantum transverse channels through the constriction. One can think of different experimental realizations of such a physical situation, like for instance the recently developed atomic size break junctions⁴ and the split-gate S-2DEG-S SQPC of Takayanagi et al.⁵ These two situations are schematically represented in Fig. 1.

The analysis of the transport and electronic properties of such a system would involve, for the most general case where both electrodes are superconductors, the solution of the time-dependent Bogoliubov–de Gennes (BdeG) equations.¹⁵ In previous works we have developed an approach to these kind of problems in which the BdeG equations are formulated in a site representation.¹³ This representation can be viewed either as a tight-binding description of the electronic states or as a discretization of the BdeG equations. The first case would be more suitable for describing systems like an atomic size contact [Fig. 1(a)], while the second could be used to represent constrictions involving a 2DEG in semiconducting heterostructures [Fig. 1(b)]. In the



FIG. 1. Schematic representations of the two different situations discussed in Sec. II.

absence of applied fields the mean-field Hamiltonian giving rise to the BdeG equations would take the form

$$\hat{H} = \sum_{i,\sigma} (\epsilon_i - \mu) c^{\dagger}_{i\sigma} c_{i\sigma} + \sum_{i \neq j,\sigma} t_{ij} c^{\dagger}_i c_j + \sum_i (\Delta^*_i c^{\dagger}_{i\downarrow} c^{\dagger}_{i\uparrow} + \Delta_i c_{i\uparrow} c_{i\downarrow}), \qquad (1)$$

where *i*, *j* run over the sites used to represent the system. By appropriately choosing the different parameters ϵ_i , t_{ij} , and Δ_i one can model different junction geometries.¹³ In order to analyze the case of biased contacts it is convenient to simplify this model Hamiltonian taking the steplike behavior of the order parameter and electrostatic potentials in a point contact geometry into account. To do this we take the complex order parameter and the chemical potentials as constants on the left and right electrodes [denoted by (Δ_L , μ_L) and (Δ_R , μ_R), respectively]. The case of a single quantum channel connecting both electrodes can then be described by the following Hamiltonian:

$$\hat{H} = \hat{H}_L + \hat{H}_R + \sum_{\sigma} (tc_{L\sigma}^{\dagger}c_{R\sigma} + t^*c_{R\sigma}^{\dagger}c_{L\sigma}) - \mu_L \hat{N}_L - \mu_R \hat{N}_R,$$
(2)

where H_L and H_R correspond to the uncoupled electrodes while the hopping term describes the electron transfer processes between the outermost sites on both electrodes. We would like to stress that, although this is a very simple model Hamiltonian (formally equivalent to a tunnel Hamiltonian), it contains the relevant physics of a quantum point contact which depends essentially on the contact normal transmission coefficient. In our model this transmission can vary between ~0 (tunnel limit) and ~1 (ballistic regime) as a function of the coupling parameter t. This will be discussed in Sec. III.

For the case of a symmetric superconducting contact in the presence of an applied bias voltage $eV = \mu_L - \mu_R$ it is convenient to perform a gauge transformation¹⁶ by means of which the Hamiltonian (2) adopts the following time-dependent form:

$$\hat{H}(\tau) = \hat{H}_L + \hat{H}_R + \sum_{\sigma} (t e^{i\phi(\tau)/2} c^{\dagger}_{L\sigma} c_{R\sigma} + t^* e^{-i\phi(\tau)/2} c^{\dagger}_{R\sigma} c_{L\sigma}),$$
(3)

where the superconducting phase difference $\phi(\tau) = \phi_0 + 2eV\tau/\hbar$ appears as a phase factor in the hopping elements.

Within the previously introduced model, the average total current through the contact is given by

$$I(\tau) = \frac{ie}{\hbar} \sum_{\sigma} \left[t \langle c_{L\sigma}^{\dagger}(\tau) c_{R\sigma}(\tau) \rangle - t^* \langle c_{R\sigma}^{\dagger}(\tau) c_{L\sigma}(\tau) \rangle \right],$$
(4)

where, depending on the gauge choice, *t* can include a timedependent phase like in Eq. (3). The averaged quantities in Eq. (4) can be expressed in terms of the nonequilibrium Keldysh Green functions \hat{G}^{+-} .¹⁷ For the superconducting state it is convenient to introduce the 2×2 Nambu representation in which $\hat{G}_{i,j}^{+-}$ adopts the form¹³

$$\hat{G}_{i,j}^{+-}(\tau,\tau') = i \begin{pmatrix} \langle c_{j\uparrow}^{\dagger}(\tau')c_{i\uparrow}(\tau) \rangle & \langle c_{j\downarrow}(\tau')c_{i\uparrow}(\tau) \rangle \\ \langle c_{j\uparrow}^{\dagger}(\tau')c_{i\downarrow}^{\dagger}(\tau) \rangle & \langle c_{j\downarrow}(\tau')c_{i\downarrow}^{\dagger}(\tau) \rangle \end{pmatrix}.$$
(5)

In terms of the \hat{G}^{+-} , the current is given by

$$I(\tau) = \frac{2e}{\hbar} [\hat{t}\hat{G}_{RL}^{+-}(\tau,\tau) - \hat{t}^*\hat{G}_{LR}^{+-}(\tau,\tau)]_{11}, \qquad (6)$$

where \hat{t} is the Nambu representation of the hopping elements

$$\hat{t} = \begin{pmatrix} t & 0\\ 0 & -t^* \end{pmatrix}. \tag{7}$$

The problem then consists in the determination of these nonequilibrium Green functions \hat{G}^{+-} . This can be formally achieved by treating the coupling \hat{t} as a perturbation. The unperturbed Green functions correspond to the uncoupled electrodes in equilibrium. For a symmetric contact, and neglecting finite bandwidth effects, the uncoupled retarded and advanced Green functions can be expressed as

$$\hat{g}_{LL}^{r,a}(\omega) = \hat{g}_{RR}^{r,a}(\omega)$$

$$= \frac{1}{W\sqrt{\Delta^2 - (\omega \pm i\,\eta)^2}} \begin{pmatrix} -\omega \pm i\,\eta & \Delta \\ \Delta & -\omega \pm i\,\eta \end{pmatrix},$$
(8)

where *W* is an energy scale related to the normal density of states at the Fermi level by $\rho(\epsilon_F) \sim 1/(\pi W)$ and η is a small energy relaxation rate that takes into account the damping of the quasiparticle states due to inelastic processes inside the electrodes.¹⁸ On the other hand, the unperturbed $\hat{g}^{+-}(\omega)$ satisfy the relation

$$\hat{g}^{+-}(\omega) = 2\pi i \hat{\rho}(\omega) n_F(\omega), \qquad (9)$$

where $\hat{\rho}(\omega) = (1/\pi) \text{Im}[\hat{g}^a(\omega)]$ and $n_F(\omega)$ is the Fermi function.

For the coupled system, the functions $\hat{G}_{i,j}^{+-}$ can be obtained from the retarded and advanced functions by means of the integral equation

$$\hat{G}^{+-}(\tau,\tau') = \int d\tau_1 d\tau_2 [\hat{I}\delta(\tau-\tau_1) + \hat{G}^r(\tau,\tau_1)\hat{\Sigma}^r(\tau_1)]\hat{g}^{+-}(\tau_1-\tau_2)[\hat{I}\delta(\tau_2-\tau') + \hat{\Sigma}^a(\tau_2)\hat{G}^a(\tau_2,\tau')], \quad (10)$$

where $\hat{G}^{r,a}$ can be derived from their corresponding Dyson equations

$$\hat{G}^{r,a}(\tau,\tau') = \hat{g}^{r,a}(\tau-\tau') + \int d\tau_1 \hat{g}^{r,a}(\tau-\tau_1) \hat{\Sigma}^{r,a}(\tau_1) \hat{G}^{r,a}(\tau_1,\tau').$$
(11)

In the above equations the self-energies take the simple form $\hat{\Sigma}_{LL}^{r,a} = \hat{\Sigma}_{RR}^{r,a} = 0$ and $\hat{\Sigma}_{LR}^{r,a} = (\hat{\Sigma}_{RL}^{r,a})^* = \hat{t}$.

In Secs. III and IV details of the solution of these integral equations are given.

III. N-N AND N-S CONTACTS

In this section we briefly review the N-N and N-S cases. The analysis of the N-N case permits one to define the normal transmission coefficient of the contact in terms of the microscopic parameters of the model, which is necessary for making contact with the scattering approach. The equivalence of both approaches is illustrated by comparing our results for the N-S contact with those of the BTK model.³

As we shall deal with a stationary situation it is convenient to adopt the time-independent formulation based on the Hamiltonian (2). In this case the Green functions depend on the difference of its temporal arguments and integral equations (10) and (11) become simple algebraic equations when Fourier transformed. Then we have

$$\hat{G}^{r,a}(\omega) = \hat{g}^{r,a}(\omega) + \hat{g}^{r,a}(\omega)\hat{\Sigma}^{r,a}(\omega)\hat{G}^{r,a}(\omega), \qquad (12)$$

$$\hat{G}^{(+-),(-+)}(\omega) = [\hat{I} + \hat{G}^{r}(\omega)\hat{\Sigma}^{r}(\omega)]\hat{g}^{(+-),(-+)}(\omega)[\hat{I} + \hat{\Sigma}^{a}(\omega)\hat{G}^{a}(\omega)],$$
(13)

where $\hat{g}^{-+}(\omega) = -2\pi i \hat{\rho}(\omega) [1 - n_F(\omega)]$. On the other hand, it is convenient to rewrite expression (6) for the current as^{13,19}

$$I = \frac{2e}{h} t^2 \int_{-\infty}^{\infty} [g_{LL,11}^{+-} G_{RR,11}^{-+}(\omega) - g_{LL,11}^{-+} G_{RR,11}^{+-}(\omega)] d\omega,$$
(14)

where we have assumed that the left electrode is in the normal state, while the right one can be either normal or superconducting.

Let us first analyze the case where both electrodes are in the normal state. Details on the calculations of the Green functions for this case have been given elsewhere.²⁰ As in the scattering approach, the current can be written as

$$I = \frac{2e}{h} \int_{-\infty}^{\infty} T(\omega, V) [n_F(\omega - eV) - n_F(\omega)] d\omega, \quad (15)$$

where $T(\omega, V)$ is an energy-dependent transmission coefficient which is given by²¹

$$T(\omega, V) = \frac{4\pi^2 t^2 \rho_{LL}(\omega - eV) \rho_{RR}(\omega)}{|1 - t^2 g_{LL}(\omega - eV) g_{RR}(\omega)|^2}.$$
 (16)

Equation (16) adopts a simpler form in the small bias limit where the normal system exhibits an Ohmic response. This regime is valid for a bias voltage range much smaller than the typical energy scale for the variation of the normal density of states around the Fermi energy. This condition certainly holds for the case we are interested in in this paper $(eV \sim \Delta)$ and is consistent with the assumptions leading to Eq. (8). In this limit the coefficient $T(\omega, V)$ becomes a constant α , given by

$$T(\omega, V) \simeq \frac{4t^2/W^2}{(1+t^2/W^2)^2} \equiv \alpha.$$
 (17)

The normal linear conductance of this single-mode contact is then given by the Landauer formula $G_{NN} = (2e^2/h)\alpha$. Notice that α can vary between zero and one as a function of t. The $\alpha \rightarrow 0$ limit is reached both for $t/W \ll 1$ and for $t/W \gg 1$, while the ballistic limit, i.e., $\alpha \sim 1$, is reached when $t/W \sim 1$.

In Ref. 21 a detailed discussion on the derivation of Eq. (17) by a different perturbative formalism and its range of validity can be found. As stated in this reference, finite order perturbation in the coupling t/W is only valid for t/W < 1, while for t/W > 1 finite order perturbation theory breaks down together with the appearance of bound states outside the metallic band. This fact could lead to the conclusion that Eq. (17) is not valid for t/W > 1. However, being the result of the summation of the complete infinite series, Eq. (17) is actually a nonperturbative result valid even for the somewhat academic case t/W > 1. In fact, by comparing this expression with the normal transmission coefficient of the δ -like scattering potential model used by BTK,³ the equivalence of both models arises by identifying $Z = [1 - (t/W)^2]/(2t/W)$, where Z is the parameter controlling the barrier strength. Thus, one can associate the case t/W < 1 with a repulsive barrier (Z>0), and the case t/W>1 with an attractive δ -like potential (Z<0), which certainly would lead to a transmission lower than 1 and the presence of bound states.

In the *N-S* case $(\Delta_L=0, \Delta_R=\Delta)$ starting from Eqs. (12) and (13) after some simple algebra we obtain the following expression for the current as the sum of four different contributions $I=I_1+I_2+I_3+I_A$, where

$$I_{1} = \frac{8e}{h} \pi^{2} t^{2} \int_{-\infty}^{\infty} d\omega |1 + tG_{RL,11}^{r}(\omega)|^{2} \rho_{LL,11}(\omega - eV) \rho_{RR,11}(\omega) [n_{F}(\omega - eV) - n_{F}(\omega)],$$

$$I_{2} = -\frac{16e}{h} \pi^{2} t^{2} \int_{-\infty}^{\infty} d\omega \operatorname{Re}\{tG_{LR,21}^{a}(\omega) [1 + tG_{RL,11}^{r}(\omega)]\} \rho_{LL,11}(\omega - eV) \rho_{RR,12}(\omega) [n_{F}(\omega - eV) - n_{F}(\omega)],$$

$$I_{3} = \frac{8e}{h} \pi^{2} t^{4} \int_{-\infty}^{\infty} d\omega |G_{RL,12}(\omega)|^{2} \rho_{LL,11}(\omega - eV) \rho_{RR,22}(\omega) [n_{F}(\omega - eV) - n_{F}(\omega)],$$

$$I_{A} = \frac{8e}{h} \pi^{2} t^{4} \int_{-\infty}^{\infty} d\omega |G_{RR,12}(\omega)|^{2} \rho_{LL,11}(\omega - eV) \rho_{LL,22}(\omega + eV) [n_{F}(\omega - eV) - n_{F}(\omega + eV)].$$
(18)

Written in this form, each contribution has a clear interpretation in terms of elementary processes that can be identified by inspection of the intervening spectral densities. Although there is a formal resemblance of the above expressions with those of tunnel theory²² Eq. (18) contains all possible processes up to infinite order in t. Thus, I_1 corresponds to normal electron transfer between the electrodes, while I_2 corresponds also to a net transfer of a single electron with creation or annihilation of pairs as an intermediate state. On the other hand, I_3 arises from processes where an electron in the normal electrode is converted into a hole in the superconducting side, i.e., processes with "branch crossing" in the BTK language. Finally, I_A arises from Andreev reflection processes in which an electron [with an associated spectral weight $\rho_{LL,11}(\omega - eV)$] is transmited from the left to the right electrode with a hole reflecting backwards into the normal electrode [with an associated spectral weight $\rho_{LL,22}(\omega + eV)$] while a Cooper pair is created in the superconducting side with a probability proportional to $|G_{RR,12}(\omega)|^2$.

As expected, the only nonzero contribution for $eV < \Delta$ is

 I_A , while all processes contribute for $eV > \Delta$. With the same simplifying assumptions leading to Eq. (17) the differential conductance at zero temperature adopts the simple form

$$G_{NS}(V) = \frac{4e^2}{h} \frac{\alpha^2}{(2-\alpha)^2 - 4(1-\alpha)(eV/\Delta)^2}, \quad eV {\leqslant} \Delta,$$

$$G_{NS}(V) = \frac{4e^2}{h} \frac{\alpha}{\alpha + (2-\alpha)\sqrt{1 - (\Delta/eV)^2}}, \quad eV > \Delta.$$
(19)

This expression can be shown to be equivalent to the one obtained from the BTK model³ with the correspondence $Z = [1 - (t/W)^2]/(2t/W)$ commented on above.

It is worth noticing that the differential conductance rises from $(4e^{2}/h)\alpha^{2}/(2-\alpha)^{2}$ at V=0 to the value $4e^{2}/h$ at $eV=\Delta$, this last value being independent of the contact transmission. This result can never be obtained within any finite order perturbative approximation in t, but requires an infinite order calculation.²³ These sorts of nonperturbative features are also very important in the S-S case,²⁴ as will be discussed in the next section.

Finally, it is possible to obtain from Eq. (18) an analytical expression of the total current at zero temperature. For $eV>\Delta$ this can be written as $I=I_1+I_2$ with

$$I_{1} = \frac{e\Delta}{h} \frac{\alpha^{2}}{(2-\alpha)\sqrt{1-\alpha}} \ln \left[\frac{1 + [2\sqrt{1-\alpha}/(2-\alpha)]}{1 - [2\sqrt{1-\alpha}/(2-\alpha)]} \right],$$

$$I_{2}(x) = \frac{4e}{h} \Delta \left[\frac{\alpha^{2}}{4(1-\alpha)} + \frac{\alpha}{x[\alpha + (2-\alpha)\sqrt{1-x^{2}}]} - \frac{\alpha(2-\alpha)^{2}x}{4(1-\alpha)[\alpha + (2-\alpha)\sqrt{1-x^{2}}]} + \frac{\alpha^{2}(2-\alpha)}{8(1-\alpha)^{3/2}} \ln \left(\frac{(x/(1+\sqrt{1-x^{2}}) + 1/\sqrt{1-\alpha})(1-1/\sqrt{1-\alpha})}{(x/(1+\sqrt{1-x^{2}}) - 1/\sqrt{1-\alpha})(1+1/\sqrt{1-\alpha})} \right) \right],$$
(20)

where I_1 is the gap contribution to the total current, I_2 is the contribution coming from energies outside the gap and $x = \Delta/eV$. This allows one to analyze with detail the "excess" current, defined as $I_{\text{exc}} = \lim_{V \to \infty} (I_{NS} - I_{NN})$, as a function of the contact transparency. We find $I_{\text{exc}} = I_{\text{exc}_1} + I_{\text{exc}_2}$

$$I_{\text{exc}_{1}} = \frac{e\Delta}{h} \frac{\alpha^{2}}{(2-\alpha)\sqrt{1-\alpha}} \ln\left[\frac{1+\left[2\sqrt{1-\alpha}/(2-\alpha)\right]}{1-\left[2\sqrt{1-\alpha}/(2-\alpha)\right]}\right],$$
$$I_{\text{exc}_{2}} = \frac{e\Delta}{h} \alpha^{2}\left[\frac{1}{1-\alpha} + \frac{2-\alpha}{2(1-\alpha)^{3/2}} \ln\left(\frac{1-\sqrt{1-\alpha}}{1+\sqrt{1-\alpha}}\right)\right],$$

where I_{exc_1} and I_{exc_2} are, respectively, the contributions coming from energies inside and outside the gap. As can be easily checked, $I_{\text{exc}_1} > 0$ while $I_{\text{exc}_2} < 0$ the total excess current being always positive. For $\alpha = 1$ the well-known result^{25,29} for the ballistic contact $I_{\text{exc}} = (8/3)e\Delta/h$ is recovered.

IV. THE S-S CONTACT

A. An efficient algorithm for evaluating the ac current

As commented on in Sec. II, for the case of a voltagebiased S-S contact it is convenient to start from the Hamiltonian (3) in which the applied bias is taken into account through a time-dependent phase factor in the hopping element, which in a Nambu representation has the form

$$\hat{t} = \begin{pmatrix} t e^{i\phi(\tau)/2} & 0\\ 0 & -t e^{-i\phi(\tau)/2} \end{pmatrix},$$
(21)

where $\phi = \phi_0 + 2eV\tau/\hbar$ is the time-dependent superconducting phase difference.

This explicit time dependence indicates that all dynamic quantities can be expanded as a Fourier series in all possible harmonics of the fundamental frequency $\omega_0 = 2eV/\hbar$.⁷ For instance, the total current can be written as

$$I(\tau) = \sum_{m} I_{m} e^{im\omega_{0}\tau}.$$
 (22)

We shall now show how these Fourier coefficients, I_m , can be efficiently evaluated within the nonequilibrium Green function formalism. Let us first notice that the nonequilibrium Green functions appearing in Eqs. (10) and (11) do not depend only on the difference of their temporal arguments, and have therefore a generalized Fourier expansion of the form^{26,27}

$$\hat{G}(\tau,\tau') = \frac{1}{2\pi} \sum_{n} \int d\omega e^{-i\omega\tau} e^{i(\omega+n\omega_0/2)\tau'} \hat{G}(\omega,\omega+n\omega_0/2).$$
(23)

Hereafter we shall use the notation $\hat{G}_{nm}(\omega)$ = $\hat{G}(\omega + n\omega_0/2, \omega + m\omega_0/2)$. Different Fourier components \hat{G}_{nm} are related by $\hat{G}_{nm}(\omega) = \hat{G}_{n-m,0}(\omega + m\omega_0/2)$. For the particular gauge choice adopted here, it is useful to express all quantities in terms of a renormalized hopping which satisfies its own Dyson equation

$$\hat{T}^{a,r}(\tau,\tau') = \hat{t}(\tau)\delta(\tau-\tau') + \int d\tau_1 d\tau_2 \hat{t}(\tau)\hat{g}^{a,r}(\tau-\tau_1)\hat{t}^{\dagger}(\tau_1) \\ \times \hat{g}^{a,r}(\tau_1-\tau_2)\hat{T}^{a,r}(\tau_2,\tau').$$
(24)

This quantity can be viewed as the total hopping amplitude arising from summing up all processes in which one electron is transferred. Clearly, it is formally equivalent to use a renormalized hopping instead of renormalized propagators as they are linked by relations like $\hat{G}_{LL}(\tau,\tau')\hat{t}(\tau') = \int d\tau_1 \hat{g}_L(\tau-\tau_1)\hat{T}_{LR}(\tau_1,\tau')$. The current components can now be expressed in terms of the renormalized hopping elements $\hat{T}_{nm}^{a,r}(\omega)$ as

$$I_{m} = \frac{2e}{h} \int d\omega \sum_{n} \left[\hat{T}_{0n}^{r} \hat{g}_{nn}^{+-} \hat{T}_{nm}^{r\dagger} \hat{g}_{mm}^{a} - \hat{g}_{00}^{r} \hat{T}_{0n}^{r} \hat{g}_{nn}^{+-} \hat{T}_{nm}^{r\dagger} + \hat{g}_{00}^{r} \hat{T}_{0n}^{a\dagger} \hat{g}_{nn}^{+-} \hat{T}_{nm}^{a} - \hat{T}_{0n}^{a\dagger} \hat{g}_{nn}^{+-} \hat{T}_{nm}^{a} \hat{g}_{mm}^{a} \right]_{11}, \quad (25)$$

where we have eliminated the site indexes L and R in the uncoupled Green functions due to the left-right symmetry of the contact.

The problem is then reduced to that of the evaluation of the components \hat{T}_{nm} . From Eq. (24) it can be shown that the components \hat{T}_{nm} (both retarded and advanced parts) satisfy a set of linear equations of the form

$$\hat{T}_{nm} = \hat{t}_{nm} + \hat{\epsilon}_n \hat{T}_{nm} + \hat{V}_{n,n-2} \hat{T}_{n-2,m} + \hat{V}_{n,n+2} \hat{T}_{n+2,m} \,.$$
(26)

These equations are mathematically equivalent to those describing the motion of electrons in a tight-binding linear chain with "site energies," $\hat{\epsilon}_n$, and "nearest-neighbor couplings," $\hat{V}_{n,n-2}$ and $\hat{V}_{n,n+2}$. The detailed expression of $\hat{\epsilon}_n$ and $\hat{V}_{n,m}$ in terms of the unperturbed Green functions are given in Appendix A. This analogy allows us to obtain the Fourier coefficients \hat{T}_{nm} using standard recursion techniques. One can show (see Appendix A) that the following recursive relation holds:

$$\hat{T}_{n+2,m}(\omega) = \hat{z}^{+} [\omega + (n-1)\omega_{0}] \hat{T}_{nm}(\omega), \quad n \ge 1,$$

$$\hat{T}_{n-2,m}(\omega) = \hat{z}^{-} [\omega + (n+1)\omega_{0}] \hat{T}_{nm}(\omega), \quad n \le -1,$$
(27)

where the transfer matrix \hat{z}^{\pm} satisfy the equation

$$\hat{z}^{\pm}(\omega) = [\hat{I} - \hat{\epsilon}_{\pm 3} - \hat{V}_{\pm 3, \pm 5} \hat{z}^{\pm}(\omega \pm \omega_0)]^{-1}.$$
 (28)

Clearly, as the transfer matrix \hat{z}^{\pm} connects consecutive harmonics of \hat{T} , it can be viewed as a generating function which introduces the effect of a unitary Andreev reflection process. The problem has been reduced to the calculation of only two matrix coefficients like, for instance, $\hat{T}_{1,0}$ and $\hat{T}_{-1,0}$ as a starting point for the generating equations (27) (see Appendix A for details).

In summary, the basic mathematical difficulty lies in the evaluation of the transfer matrix functions \hat{z}^{\pm} from Eq. (28). Although Eq. (28) looks simple, it is nevertheless hard to solve analytically for arbitrary values of V. The analytical results presented in this paper are limited to the $eV/\Delta \rightarrow 0$



FIG. 2. The dc current-voltage characteristic of a *S*-*S* contact for different values of the normal transmission at zero temperature.

and $eV/\Delta \rightarrow \infty$ cases where some simplifying relations hold. For intermediate voltages, an accurate numerical solution of Eq. (28) can be obtained.

B. Analysis of ac and dc I-V characteristics

In this subsection we analyze the general features of the *I-V* characteristics of an *S-S* contact obtained using our formalism. Let us start by briefly discussing the dc current, $I_0(V)$, for different values of the transmission, as shown in Fig. 2. Although the overall qualitative features of these curves have been known since the works of Octavio *et al.*,²⁸ Zaitsev,²⁵ and Arnold,²⁶ more quantitative and detailed analysis are being reported in recent publications.^{6,8} The results of Fig. 2 are in agreement with those reported recently by Averin and Bardas⁸ which were obtained using the scattering approach.

Two relevant features of these curves are the subharmonic gap structure for $eV < 2\Delta$ and the excess current for $eV \gg \Delta$. As can be observed, the subgap structure becomes progressively more pronounced with decreasing transmission. Eventually, when $\alpha \ll 1$ the current steps at positions $eV \sim 2\Delta/n$ can be clearly resolved. In this limit one can isolate the elementary processes which give rise to these steps. It can be shown that in the tunnel limit the *n*th step can be calculated as

$$\delta I_0^{(n)} = \lim_{eV \to 2\Delta^+/n} \frac{8e}{h} \pi^2 n t^{2n}$$

$$\times \int_{\Delta}^{neV - \Delta} d\omega \bigg[\prod_{i=1}^{n-1} \bigg| g_{12}(\omega - ieV) \bigg|^2 \bigg]$$

$$\times \rho_{11}(\omega) \rho_{22}(\omega - neV). \tag{29}$$

By comparison of Eq. (29) with the expression of I_A in Eq. (18) it becomes clear that the steps inside the gap are due

to the opening of a new Andreev reflection channel whenever $eV = 2\Delta/n$. Calculation of the integrals in Eq. (29) leads to

$$\delta I_0^{(n)} = \frac{e\Delta\alpha^n}{\hbar} \left(\frac{2n}{4^{2n-1}}\right) \left(\frac{n^n}{n!}\right)^2,\tag{30}$$

in agreement with the recent prediction of Bratus et al.⁶ On the other hand, when $\alpha \rightarrow 1$ the subgap structure is completely washed out and there appears an excess current even in the small bias limit.

The other relevant feature of the dc current, namely the large voltage excess current, can be analytically evaluated within our model for any transmission value. The main simplification in this limit comes from the fact that only the lowest order Andreev reflection process gives a significant contribution to the excess current.²⁸ This implies that one can truncate the system of equations (26) for harmonic indexes n > 1, the resulting simplified system can then be solved explicitly for $\hat{T}_{1,0}(\omega)$ and $\hat{T}_{-1,0}(\omega)$ (for details see Appendix B). As shown in this Appendix the simple result $I_{\text{exc}}^{SS} = 2I_{\text{exc}}^{NS}$ is obtained for any value of the transmission. Although this is the expected physically sound result, to our knowledge, it has not been shown explicitly before except for the ballistic case.^{25,29} Moreover, some authors have reported the existence of a negative excess current for low transmissions.³⁰ which seems to be in contradiction with the above result. However, one should notice that the excess current as defined above is an asymptotic quantity (only valid in the $eV/\Delta \rightarrow \infty$ limit). When corrections of order Δ/eV are taken into account one actually can have a defect instead of an excess current for sufficiently low transmission.

The algorithm described in Sec. IV A allows an efficient evaluation of the higher order ac components of the current. For the following analysis we decompose the ac current, Eq. (22), into its dissipative and nondissipative contributions given, respectively, by

$$I_D = I_0 + \sum_m I_m^D \cos(m\omega_0 \tau)$$
(31)

and

$$I_{S} = \sum_{m} I_{m}^{S} \sin(m \omega_{0} \tau), \qquad (32)$$

where $I_m^D = 2 \operatorname{Re}(I_m)$ and $I_m^S = -2 \operatorname{Im}(I_m)$. The results obtained for the first three I_m^D and I_m^S components are depicted in Fig. 3 and Fig. 4. As can be observed, these components become exponentially small for bias voltages larger than Δ/n . On the contrary, when $eV \leq \Delta/n$ the decay of the ac components with increasing n becomes slower. The analysis of the higher order components reveals a decay for $eV \leq \Delta/n$ close to an inverse power law. As a consequence of this slow decay, one is forced to take an increasing number of ac components into account in order to adequately describe the behavior at small bias. This will be the subject of the next subsection.



FIG. 3. The first three ac components of the dissipative current for different values of the normal transmission at zero temperature.

C. Small bias regime

In this subsection we concentrate on the $eV/\Delta \rightarrow 0$ case, which turns out to exhibit a remarkable variety of different regimes according to the values of the parameters $\alpha \Delta$ and the inelastic scattering rate η . As it is well known, the main difficulty for obtaining quantitative results in this limit lies in the fact that the number of MAR's contributing to the current grows with decreasing V as $\sim \Delta/eV$.²⁶ Furthermore, the amplitudes of these multiple processes do not decay when $(V, \eta) \rightarrow 0$ leading to the appearance of divergencies in the perturbative expansion in the coupling \hat{t} .⁷ Again, a complete summation of the perturbative series is needed in order to regularize these divergencies. An additional difficulty arises, as will be discussed below, from the fact that the limits $V \rightarrow 0$ and $\eta \rightarrow 0$ do not actually commute.

When decreasing the bias voltage two main situations can be reached depending on the strength of the inelastic scattering rate at the superconducting electrodes: the case of $eV/\Delta \rightarrow 0$ and finite η has been discussed by the present authors in recent publications;⁷ on the other hand, the case of small V/Δ and negligible η has been recently addressed to



FIG. 4. Same as Fig. 4 for the nondissipative current.

by Averin and Bardas.⁸ In what follows we summarize the main results for both regimes and analyze the conditions for their actual observability in a real SQPC.

Within our formalism, analytical results in the small bias limit become feasible since the transfer matrix $\hat{z}^{\pm}(\omega)$ tends to a scalar quantity having the form of a simple phase factor inside the gap region. As shown in Appendix C for $(\eta, V) \rightarrow 0$ we find

$$\hat{z}^{\pm}(\omega) = z(\omega) = e^{i\varphi(\omega)}, \quad \Delta\sqrt{1-\alpha} \leq |\omega| \leq \Delta, \quad (33)$$

where

$$\varphi(\omega) = \arcsin\left(\frac{2}{\alpha\Delta^2}\sqrt{\Delta^2 - \omega^2}\sqrt{\omega^2 - (1 - \alpha)\Delta^2}\right)$$

As the multiple Andreev processes are generated by successive applications of $\hat{z}(\omega)$, Eq. (33) indicates that these processes do not decay in this limit inside the gap region. This infinite series of MAR gives rise to the well-known bound state spectrum of a current-carrying SQPC at zero bias voltage.³¹ As shown in Appendix C, the positions of these bound states are determined by the condition $\varphi(\omega) = \phi$. The



FIG. 5. Current density for the dc component I_0 within the linear regime discussed in Sec. IV C. (a), (b), and (c) correspond to transmission values $\alpha = 1$, 0.65, and 0.04, respectively. In all cases the full line corresponds to $\eta/\Delta = 1/10$, the dotted line to $\eta/\Delta = 1/25$, and the broken line to $\eta/\Delta = 1/100$. The thermal factor sech²($\beta \omega/2$) [see Eq. (C8)] has been extracted from the current density.

presence of a small but finite η or V (whichever is larger) introduces an effective damping into the otherwise infinite series of MAR.

When this effective damping is due to a finite η ($eV \ll \eta$) a linear regime can be defined where the total current is given by $I_S(\phi) + G(\phi)V$, $G(\phi)$ being a phase-dependent linear conductance.^{25,7} Within this linear regime, one can identify two different subregimes according to the ratio $\eta/\alpha\Delta$. The case $\eta/\alpha\Delta \ll 1$ corresponds to a situation where MAR's are very weakly damped and give the dominant contribution to the current. The physical picture one can have in mind is that of electrons and holes Andreev-reflecting between the electrodes for a very long time before being inelastically scattered.³² In order to illustrate the dominant contribution of the processes inside the gap for the weakly damped case, we represent in Fig. 5 the current den-

sity corresponding to the I_0 component for three values of the transmission. Three important features of this linear regime are displayed in this figure: first, the current density inside the gap increases as $\sim 1/\eta$ therefore giving the dominant contribution in the weakly damped case; second, there is a region inside the gap of width $2\Delta\sqrt{1-\alpha}$ in which the current density vanishes. This is the forbidden energy region for bound states at a given transmission. Finally, in Fig. 5(c) one can observe that the contribution of the continuum outside the gap becomes important as $\alpha < \eta/\Delta$. In the limit $\eta/\alpha \Delta \ge 1$ a second subregime is reached where the contributions of MAR's are heavily damped and the current is dominated by single quasiparticle tunneling processes. The transition between these two subregimes has been analyzed with detail in Refs. 7.

In order to identify the actual subregime for a real SQPC an estimation of the order of magnitude of η is needed. In Ref. 18 η is estimated from the electron-phonon interaction to be a small fraction of the gap for traditional superconductors. Thus, our theory predicts that a real SQPC would generally fall into the weakly damped case except for extremely low transmissions.

For this subregime the supercurrent I_s and the linear conductance $G(\phi)$ can be obtained analytically as discussed in Appendix C. In particular, for $G(\phi)$ one obtains

$$G(\phi) = \frac{2e^2}{h} \frac{\pi}{16\eta} \left[\frac{\Delta \alpha \sin \phi}{\sqrt{1 - \alpha \sin^2(\phi/2)}} \operatorname{sech} \left(\frac{\beta \omega_s}{2} \right) \right]^2 \beta,$$
(34)

where ω_s is the position of the bound states inside the gap and $\beta = 1/k_BT$. This expression for large transmission and small temperatures gives a phase-dependence which is in qualitative agreement with the few available experimental results, performed in nonmesoscopic contacts.³³ The unusual phase dependence of Eq. (34) which deviates strongly from the $\cos(\phi)$ form predicted by the standard tunnel theory may explain the old controversy between tunnel theory and experiments known as the $\cos(\phi)$ problem.^{34,35}

On the other hand, when the truncation of the infinite series of MAR's is caused by a finite V (with negligible η), analytical results have only been obtained in the quasiballistic limit, i.e., $\alpha \rightarrow 1$. A closer inspection of the *I*-V curves in the small bias region and for $\alpha \sim 1$ reveals that the supercurrent components decay exponentially from its value at V=0 with a collapsing width $\sim (1-\alpha)\Delta$. This is illustrated in Fig. 6(a) where a blow up of the behavior of I_1^S for small bias voltages and quasiballistic transmissions is shown. In the limit $\alpha \rightarrow 1$ the supercurrent becomes a δ function at V=0. On the contrary, the dissipative components in this same limit tend to a finite value outside the region of width $\sim (1-\alpha)\Delta$. This behavior is shown in Fig. 6(b) where I_1^D is plotted in the same magnified scale as I_1^S . The summation of these dissipative components for $\alpha = 1$ and very small V yields (see Appendix C)

$$I_D(\phi) = \frac{e\Delta}{\hbar} |\sin(\phi/2)| \operatorname{sgn} V, \qquad (35)$$

in agreement with the result recently derived by Averin and Bardas.⁸ The existence of a region of decreasing width



FIG. 6. Behavior of the first nondissipative (a) and dissipative (b) ac components in the very small voltage range close to ballistic conditions. These results have been obtained for negligible η .

 $V \sim (1 - \alpha) \Delta$ in which this crossover from supercurrent to dissipative current takes place can be associated with the collapse of the forbidden region for MAR's inside the superconducting gap taking place when $\alpha \rightarrow 1$. In this way, when V is small compared to the width of the forbidden region the excitation of quasiparticles from states at $\omega < -\Delta \sqrt{1-\alpha}$ into states at $\omega > \Delta \sqrt{1-\alpha}$ is negligible and there is no appreciable dissipative current; whereas the opposite situation holds for $V > \sqrt{1 - \alpha} \Delta$. Averin and Bardas⁸ have described this crossover as a Landau-Zener transition in which the nondissipative and the dissipative components scale with α and V as (1-p) and p, respectively, where p $= \exp[-\pi(1-\alpha)\Delta/eV]$. The numerical results for sufficiently small eV/Δ and $(1-\alpha)$ are well fitted by these scaling laws. However, a careful analysis reveals that their range of validity around V=0 and $\alpha=1$ decreases strongly when increasing the component number.

In summary, in this small bias limit one can identify four different subregimes depending on the relative values of parameters η , $\alpha\Delta$, and eV. The prediction of the actual behavior of a real SQPC in this limit would therefore require a careful estimation of all these parameters. In this respect, one

should keep in mind that while eV and α can be varied experimentally in a rather controlled way, the inelastic scattering rate η is an intrinsic property of the superconducting electrodes much more difficult to control. The unavoidable presence of some degree of inelastic scattering can prevent the actual observability of the crossover from nondissipative to dissipative behavior described after Eq. (35). The requirement of $eV \sim (1-\alpha)\Delta$ together with that of $\alpha \sim 1$ can actually imply $eV < \eta$ which would rather correspond to the linear regime. Finally, when considering the experimental test of all these theoretical predictions the relevance of noise in a real SQPC should be taken into account. Recent theoretical predictions^{36,37} suggest that the magnitude of thermal noise in a single-mode superconducting device can be extremely large near ballistic conditions.

V. CONCLUDING REMARKS

In the present work we have presented a Hamiltonian approach for describing the transport properties of single-mode *N-S* and *S-S* contacts.

It has been explicitly demonstrated that this approach is, with some simplifying assumptions, equivalent to the phenomenological scattering approach. We believe that the present work can help clarify the somewhat recurrent discussion about the unsuitability of a Hamiltonian approach for obtaining the transport properties of a N-S or S-S contact: when performing the calculations up to infinite order in the coupling t all the unphysical divergences are eliminated and the results become equivalent to those of scattering theory.

On the other hand, the present approach has been applied to discuss in detail the dc and ac *I-V* characteristics of a SQPC. In particular, we have concentrated on the less understood small bias voltage limit where one can identify four different subregimes depending on the values of the contact transmission and inelastic scattering rate. Finally, we have discussed the conditions for the experimental observability of the theoretical predictions in this limit.

Although in the present work we have restricted the discussion to the simplest single-mode case with an energyindependent transmission coefficient, the general model introduced in Sec. II can describe more complex situations which may be relevant for a closer comparison with recent experiments.⁵ Work along this line is under progress.

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APPENDIX A

In this appendix we describe the algorithm for evaluating the ac current components in a *S*-*S* biased contact. As has been pointed out in Sec. IV, we can express the current in terms of the retarded and advanced Fourier components of the renormalized hopping $\hat{T}_{nm}(\omega)$ satisfying Eq. (26)

$$\hat{T}_{nm} = \hat{t}_{nm} + \hat{\epsilon}_n \hat{T}_{nm} + \hat{V}_{n,n-2} \hat{T}_{n-2,m} + \hat{V}_{n,n+2} \hat{T}_{n+2,m},$$
(A1)

where the matrix coefficients $\hat{\epsilon}_n$ and \hat{V}_{nm} can be expressed in terms of the uncoupled Green functions as

$$\hat{\epsilon}_n = t^2 \begin{pmatrix} g_{n+1}g_n & g_{n+1}f_n \\ g_{n-1}f_n & g_{n-1}g_n \end{pmatrix},$$
(A2)

$$\hat{V}_{n,n+2} = -t^2 f_{n+1} \begin{pmatrix} f_{n+2} & g_{n+2} \\ 0 & 0 \end{pmatrix},$$
 (A3)

$$\hat{V}_{n,n-2} = -t^2 f_{n-1} \begin{pmatrix} 0 & 0 \\ g_{n-2} & f_{n-2} \end{pmatrix},$$
(A4)

where $f(\omega) \equiv g_{12}(\omega) = g_{21}(\omega)$ and $g(\omega) \equiv g_{11}(\omega) = g_{22}(\omega)$ due to electron-hole symmetry. In the above equations the shorthand notation $g_n = g(\omega + n\omega_0/2)$ is used. Moreover, the site indexes in the Green functions have been omitted since we are considering a symmetric contact.

As commented on in Sec. IV, the linear equations (A1) are analogous to those describing a tight-binding chain with nearest-neighbor hopping parameters $\hat{V}_{n,n+2}$ and $\hat{V}_{n,n-2}$. A solution can then be obtained by standard recursive techniques. It is straightforward to show that the following recursive relations between the coefficients \hat{T}_{nm} hold:

$$\hat{T}_{n+2,m}(\omega) = \hat{z}^{+} [\omega + (n-1)\omega_{0}] \hat{T}_{nm}(\omega), \quad n \ge 1,$$
$$\hat{T}_{n-2,m}(\omega) = \hat{z}^{-} [\omega + (n+1)\omega_{0}] \hat{T}_{nm}(\omega), \quad n \le -1,$$
(A5)

where the transfer matrix $\hat{z}^{\pm}(\omega)$ satisfies the equation

$$\hat{z}^{\pm}(\omega) = [\hat{I} - \hat{\epsilon}_{\pm 3} - \hat{V}_{\pm 3, \pm 5} \hat{z}^{\pm}(\omega \pm \omega_0)]^{-1}.$$
 (A6)

One can see from Eq. (A6) that $\hat{z}^+(\omega)$ and $\hat{z}^-(\omega)$ are related by $\hat{z}^-(\omega, V) = \hat{\sigma}_x \hat{z}^-(\omega, -V) \hat{\sigma}_x$, where $\hat{\sigma}_x$ is the corresponding Pauli matrix.

By virtue of the relation $\hat{T}_{nm}(\omega) = \hat{T}_{n-m,0}(\omega + m\omega_0/2)$, one can write the current components given by Eq. (25) in terms of $\hat{T}_{n0}(\omega) \equiv \hat{T}_n$. Using recursive relations (A5) the calculation can be reduced to a closed system for coefficients \hat{T}_1 and \hat{T}_{-1} :

$$[\hat{I} - \hat{\epsilon}_{1} - \hat{V}_{13}\hat{z}^{+}(\omega)]\hat{T}_{1} = \hat{t}_{10} + \hat{V}_{1,-1}\hat{T}_{-1},$$

$$[\hat{I} - \hat{\epsilon}_{-1} - \hat{V}_{-1,-3}\hat{z}^{-}(\omega)]\hat{T}_{-1} = \hat{t}_{-10} + \hat{V}_{-1,1}\hat{T}_{1}.$$
 (A7)

The remaining task is the calculation of the transfer matrix $\hat{z}^+(\omega)$. It can be shown that the solution of Eq. (A6) is a diagonal matrix whose elements can be expressed in terms of a scalar function $\lambda^+(\omega)$

$$\hat{z}^{+}(\boldsymbol{\omega}) = -t^{2} \begin{pmatrix} f_{2}f_{3}\frac{\delta_{0}^{+}\delta_{1}^{+}}{\lambda_{0}^{+}\lambda_{1}^{+}} & 0\\ 0 & f_{1}f_{2}\frac{\delta_{-1}^{+}\delta_{0}^{+}}{\lambda_{0}^{+}\lambda_{1}^{+}} \end{pmatrix}, \quad (A8)$$

where $\lambda_n^+ = \lambda^+(\omega + n\omega_0/2)$ and $\delta_n^+ = (\lambda_n^+ - g_{n+2})/t^2 f_{n+2}^2$ The function $\lambda^+(\omega)$ satisfies the following equation

$$\lambda_0^+ = a + b\lambda_0^+ + c\lambda_2^+ + d\lambda_0^+\lambda_2^+, \qquad (A9)$$

where, taking into account Eq. (17), the coefficients can be written as $a = g_2 + (t^2/W^2)g_3$, $b = t^2g_2g_3$, $c = -t^2[g_2g_3 - (t^2/W^4)]$, and $d = t^2[g_3 + (t^2/W^2)g_2]$. For an arbitrary bias voltage, Eq. (A9) can only be solved numerically. However, as we show in Appendices B and C it is possible to obtain analytical solutions in the two special cases $\omega_0 \rightarrow 0$ and $\omega_0 \rightarrow \infty$.

Once $\hat{z}^+(\omega)$ has been determined one can calculate the coefficients \hat{T}_1 and \hat{T}_{-1} from Eq. (A7)

$$\hat{T}_{1} = \frac{-t}{1 - t^{2} \lambda_{2}^{-} \lambda_{-1}^{+}} \begin{pmatrix} t^{4} f_{0} f_{1} \delta_{2}^{-} \delta_{-1}^{+} & t^{2} f_{1} \delta_{-1}^{+} \\ t^{2} f_{0} \delta_{2}^{-} & 1 \end{pmatrix}, \quad (A10)$$

$$\tilde{T}_{-1}(\omega, V) = -\hat{\sigma}_x \tilde{T}_1(\omega, -V)\hat{\sigma}_x, \qquad (A11)$$

where $\lambda_n^-(\omega, V) = \lambda_n^+(\omega, -V)$ and $\delta_n^-(\omega, V) = \delta_n^+(\omega, -V)$. The rest of the coefficients \hat{T}_n can be calculated from Eqs. (A5):

$$\begin{split} \hat{T}_{2n+1} = & \left[\prod_{i=1}^{n} \hat{z}^{+} [\omega + (i-1)\omega_{0}] \right] \hat{T}_{1}, \quad n > 0 \\ & \hat{T}_{-n} = -\hat{\sigma}_{x} \hat{T}_{n}(\omega, -V) \hat{\sigma}_{x}, \quad n > 0. \end{split} \tag{A12}$$

Finally, the current components, separated into dissipative and nondissipative parts [Eqs. (31) and (32)], can be calculated from the expressions

$$I_0 = -\frac{4e}{h} \int_{-\infty}^{\infty} d\omega \sum_{n = \text{odd}} \text{Re}\{\text{Tr}[\hat{\sigma}_z \hat{T}_n^{\dagger}(\omega)\hat{g}_n^{+-} \hat{T}_n(\omega)\hat{g}_0^a]\},$$
(A13)

$$I_m^D = -\frac{4e}{h} \int_{-\infty}^{\infty} d\omega \sum_{n=\text{odd}} \operatorname{Re}(\operatorname{Tr}\{\hat{\sigma}_z[\hat{T}_{n+m}^{\dagger}(\omega - m\omega_0/2) + \hat{T}_{n-m}^{\dagger}(\omega + m\omega_0/2)\hat{g}_n^{\dagger} - \hat{T}_n(\omega)\hat{g}_0^a), \quad (A14)$$

$$I_{m}^{S} = \frac{4e}{h} \int_{-\infty}^{\infty} d\omega \sum_{n = \text{odd}} \text{Im}(\text{Tr}\{\hat{\sigma}_{z}[\hat{T}_{n+m}^{\dagger}(\omega - m\omega_{0}/2) - \hat{T}_{n-m}^{\dagger}(\omega + m\omega_{0}/2)\hat{g}_{n}^{+-}\hat{T}_{n}(\omega)\hat{g}_{0}^{a}).$$
(A15)

APPENDIX B

In this appendix we give details on the evaluation of the excess current for S-S contacts. In the limit $eV/\Delta \rightarrow \infty$ only

the dc current component I_0 survives. The infinite summation over *n* in Eq. (A13) can be truncated in this case neglecting the n > 1 terms. This is justified as the products $f_n f_{n+1}$ are negligible in this limit leading to a vanishing transfer matrix $\hat{z}^{\pm}(\omega)$. Physically, this is equivalent to neglecting multiple Andreev processes for $eV/\Delta \ge 1$. Then, Eq. (A13) reduces to

$$I_0 \sim$$

$$-\frac{4e}{h}\int_{-\infty}^{\infty}d\omega\sum_{n=-1,1}\operatorname{Re}\{\operatorname{Tr}[\hat{\sigma}_{z}\hat{T}_{n}^{\dagger}(\omega)\hat{g}_{n}^{+-}(\omega)\hat{T}_{n}(\omega)\hat{g}_{0}^{a}]\},$$
(B1)

with

$$\begin{split} \hat{T}_1 &\sim \frac{-t}{1-t^2\lambda_2^-\lambda_{-1}^+} \begin{pmatrix} 0 & t^2f_1\delta_{-1}^+ \\ t^2f_0\delta_2^- & 1 \end{pmatrix}, \\ \hat{T}_{-1}(\omega,V) &= -\hat{\sigma}_x\hat{T}_1(\omega,-V)\hat{\sigma}_x. \end{split}$$

On the other hand, when neglecting contributions of order Δ/eV Eq. (A9) simply yields $\lambda_n^+ \sim (g_{n+2} + it^2/W^3)/(1 - it^2g_{n+2}/W)$. We then obtain from Eq. (B1) the simple result $I_{\text{exc}}^{SS} = 2I_{\text{exc}}^{NN}$ for the excess current at zero temperature and any value of the transmission coefficient.

APPENDIX C

In this appendix we give the main steps in the analytical calculation of the current components in the limit $eV/\Delta \rightarrow 0$.

1. Linear regime $(\eta \ge eV)$

The small voltage response can be straightforwardly derived from Eqs. (A13)–(A15) by expanding the Fermi functions appearing in \hat{g}^{+-} up to first order in eV: $n_F(\omega + n\omega_0/2) \sim n_F(\omega) - (\beta/8)n\omega_0 \operatorname{sech}^2(\beta\omega/2)$ and evaluating the rest of these expressions at eV=0. The current components can be then written as

$$I_0 = \frac{2e^2}{h} \beta V \int_{-\infty}^{\infty} d\omega \operatorname{sech}^2 \left(\frac{\beta \omega}{2} \right)_{n = \operatorname{odd} > 0} n \operatorname{Re} \{ \operatorname{Tr} [\hat{\sigma}_z \hat{T}_n^{\dagger} (\hat{g}_0^a - \hat{g}_0^r) \hat{T}_n \hat{g}_0^a] \},$$
(C1)

$$I_m^D = \frac{2e^2}{h} \beta V \int_{-\infty}^{\infty} d\omega \operatorname{sech}^2 \left(\frac{\beta \omega}{2} \right) \sum_{n = \operatorname{odd} > 0} n \operatorname{Re}(\operatorname{Tr}\{\hat{\sigma}_z[\hat{T}_{n+m}^{\dagger} + \hat{T}_{n-m}^{\dagger}](\hat{g}_0^a - \hat{g}_0^r) \hat{T}_n \hat{g}_0^a\}), \tag{C2}$$

$$I_{m}^{S} = \frac{8e}{h} \int_{-\infty}^{\infty} d\omega \ n_{F}(\omega) \sum_{n = \text{odd} > 0} \text{Im}(\text{Tr}\{\hat{\sigma}_{z}[\hat{T}_{n+m}^{\dagger} - \hat{T}_{n-m}^{\dagger}](\hat{g}_{0}^{a} - \hat{g}_{0}^{r})\hat{T}_{n}\hat{g}_{0}^{a}\}).$$
(C3)

Thus, the dissipative contribution, I_D , goes to zero as $I_D(\phi) \sim G(\phi)V$, $G(\phi)$ being the phase-dependent linear conductance, while the supercurrent part, $I_S(\phi)$, tends to a finite value at V=0.

In the zero-voltage limit the coefficients \hat{T}_n adopt a simple form. The transfer matrix $\hat{z}^{\pm}(\omega)$ becomes a scalar function: $\hat{z}^+(\omega) = \hat{z}^-(\omega) \equiv z(\omega)\hat{I}$; with $z(\omega) = -t^2 f \delta^2 / \lambda^2$, where $\lambda^+(\omega) = \lambda^-(\omega) \equiv \lambda(\omega)$ satisfies the simple quadratic equation

$$t^{2}g(\omega)\lambda^{2}(\omega) - \left(1 - \frac{t^{2}}{W^{2}}\right)\lambda(w) + g(\omega) = 0.$$
(C4)

Finally, the coefficients \hat{T}_n adopt the form

$$\hat{T}_{1}(\omega) = \frac{-t}{1-t^{2}\lambda^{2}} \begin{pmatrix} t^{4}f^{2}\delta^{2} & t^{2}f\delta \\ t^{2}f\delta & 1 \end{pmatrix},$$
(C5)

$$\hat{T}_{2n+1}(\omega) = z^n(\omega)\hat{T}_1(\omega), \quad n \ge 0.$$
(C6)

Due to these simple recursive relations, the series appearing in the current components become geometrical series, which can be summed up without difficulty. In the weakly damped case, $\eta/\alpha\Delta \ll 1$, these summations lead to analytical expressions for the dissipative and nondissipative parts of the current. By solving Eq. (C4) up to corrections of order $\eta/\alpha\Delta$ one obtains

$$z(\omega) = e^{i\varphi(\omega)} - \frac{4\omega\eta}{\alpha\Delta^2} \{i + \operatorname{cotg}[\varphi(\omega)]\}, \quad \Delta\sqrt{1-\alpha} \leq |\omega| \leq \Delta,$$
(C7)

where

$$\varphi(\omega) = \arcsin\left(\frac{2}{\alpha\Delta^2}\sqrt{\Delta^2 - \omega^2}\sqrt{\omega^2 - (1 - \alpha)\Delta^2}\right)$$

The summation of the geometrical series yields

$$I_0 = \frac{2e^2}{h} \beta V \int_{-\infty}^{\infty} d\omega \operatorname{sech}^2 \left(\frac{\beta \omega}{2} \right) \operatorname{Re}\{A(\omega)\} \frac{1 + |z|^2}{(1 - |z|^2)^2},$$
(C8)

$$I_{m}^{D} = \frac{2e^{2}}{h}\beta V \int_{-\infty}^{\infty} d\omega \operatorname{sech}^{2} \left(\frac{\beta\omega}{2}\right) \operatorname{Re} \left\{ A(\omega) \left[\left[z^{m} + (z^{*})^{m} \right] \frac{1 + |z|^{2}}{(1 - |z|^{2})^{2}} + \frac{2mz^{m}}{1 - |z|^{2}} \right] \right\},$$
(C9)

$$I_{m}^{S} = \frac{8e}{h} \int_{-\infty}^{\infty} d\omega \ n_{F}(\omega) \operatorname{Im}\left\{A(\omega) \frac{(z^{*})^{m} - z^{m}}{1 - |z|^{2}}\right\},$$
(C10)

where $A(\omega) \equiv \text{Tr}[\hat{\sigma}_z \hat{T}_1^{\dagger}(\hat{g}^a - \hat{g}^r) \hat{T}_1 \hat{g}^a]$. It can be noticed that in this weakly damped limit the integrands goes like $1/\eta$ and the energy interval $\Delta \sqrt{1 - \alpha} \leq |\omega| \leq \Delta$ give the main contribution to the current.

Finally, when summing up all ac components to obtain the total dissipative and nondissipative parts, the current densities become singular at the condition $\varphi(\omega) = \phi$. This condition is satisfied for $\omega = \omega_S = \pm \Delta \sqrt{1 - \alpha \sin^2(\phi/2)}$ (i.e., at the bound-state energy levels) leading to

$$I_D(\phi) = \frac{e^2 \alpha^2 \Delta^4}{8 \eta h} \beta V \int_{-\infty}^{\infty} d\omega \operatorname{sech}^2 \left(\frac{\beta \omega}{2} \right) \frac{\sin^2 \varphi(\omega)}{\omega} \operatorname{Im} \left\{ \frac{1}{(\omega - |\omega_S| - i \eta)(\omega + |\omega_S| - i \eta)} \right\},$$
(C11)

$$I_{S}(\phi) = -\frac{2e}{h} \alpha \Delta^{2} \sin \phi \int_{-\infty}^{\infty} d\omega \ n_{F}(\omega) \operatorname{Im}\left\{\frac{1}{(\omega - |\omega_{S}| - i\eta)(\omega + |\omega_{S}| - i\eta)}\right\}.$$
(C12)

These integrals can be straightforwardly evaluated. Equation (C11) gives the expression for the phase-dependent linear conductance given in Sec. IV [Eq. (34)], while Eq. (C12) yields the well-known expression for the supercurrent in a single-mode SQPC.^{13,38}

$$I_{S}(\phi) = \frac{e\Delta^{2}\alpha}{2\hbar} \frac{\sin(\phi)}{|\omega_{S}(\phi)|} \tanh\left(\frac{\beta|\omega_{S}(\phi)|}{2}\right).$$
(C13)

2. Nonlinear regime $(\eta \ll eV)$

We first rewrite Eqs. (A13)-(A15) for the current components as

$$I_{0} = \frac{4e}{h} \int_{-\infty}^{\infty} d\omega \tanh\left(\frac{\beta\omega}{2}\right) \sum_{n=\text{odd}>0} \operatorname{Re}\{\operatorname{Tr}[\hat{\sigma}_{z}\hat{T}_{n}^{\dagger}(\hat{g}_{0}^{a} - \hat{g}_{0}^{r})\hat{T}_{n}\hat{g}_{-n}^{a}]\},$$

$$I_{m}^{D} = \frac{4e}{h} \int_{-\infty}^{\infty} d\omega \tanh\left(\frac{\beta\omega}{2}\right) \sum_{n=\text{odd}>0} \operatorname{Re}(\operatorname{Tr}\{\hat{\sigma}_{z}[\hat{T}_{n+m}^{\dagger}\hat{T}_{n-m}^{\dagger}](\hat{g}_{0}^{a} - \hat{g}_{0}^{r})\hat{T}_{n}\hat{g}_{-n}^{a}\}),$$

$$I_{m}^{S} = -\frac{4e}{h} \int_{-\infty}^{\infty} d\omega \tanh\left(\frac{\beta\omega}{2}\right) \sum_{n=\text{odd}>0} \operatorname{Im}(\operatorname{Tr}\{\hat{\sigma}_{z}[\hat{T}_{n+m}^{\dagger} - \hat{T}_{n-m}^{\dagger}](\hat{g}_{0}^{a} - \hat{g}_{0}^{r})\hat{T}_{n}\hat{g}_{-n}^{a}\}),$$
(C14)

where a rigid shift of $n\omega_0/2$ in the energy arguments of the different \hat{T}_n with respect to the ones appearing in Eqs. (A13)–(A15) has been introduced.

In the limit $eV \rightarrow 0$, the solution of Eq. (A9) is $\lambda_n^+ = \lambda [\omega + (n+2)\omega_0/2]$, where $\lambda(\omega)$ satisfies the quadratic equation (C4). The coefficients \hat{T}_n (n > 0) can then be generated starting from \hat{T}_1 and using the transfer matrix $\hat{z}^+(\omega)$. These quantities are obtained from Eqs. (A8) and (A10) making use of the $eV \rightarrow 0$ solution for λ_n^+

The resulting expressions simplify considerably in the

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ballistic limit where $\lambda_n^+ = i/t$. For energies inside the gap one obtains

$$\hat{T}_n(\boldsymbol{\omega}) = -\frac{t}{2} \prod_{j=1}^{n-1} e^{i\alpha_j} \begin{pmatrix} e^{i(\alpha_0 + \alpha_n)} & e^{i\alpha_n} \\ e^{i\alpha_0} & 1 \end{pmatrix}, \quad (C15)$$

where $\alpha_n = \arccos[(\omega + neV)/\Delta]$. As discussed in Ref. 8, when written as in Eq. (C14), the main contribution to the current in this limit comes from a small energy range around the gap edges. Evaluation of these integrals leads directly to Eq. (35).

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